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| Notice of References Cited | Application/Control No. 10/568,541 | | Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. | |
| | Examiner CAL EUSTAQUIO | | Art Unit 2612 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-2002/0121963 | 09-2002 | Kline, Paul A. | 340/310.01 |
| * | B | US-2004/0252853 | 12-2004 | Blamey et al. | 381/318 |
| * | C | US-2005/0063535 | 03-2005 | Walbeck et al. | 379/399.01 |
| * | D | US-2002/0171535 | 11-2002 | Cern, Yehuda | 340/310.07 |
| * | E | US-6,163,579 | 12-2000 | Harrington et al. | 375/257 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | |
|---|---|---|--|--|--|
| | U | | | | |
| | V | | | | |
| | W | | | | |
| | X | | | | |

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